Features

- Fast Read Access Time 70 ns
- Automatic Page Write Operation
 - Internal Address and Data Latches for 64 Bytes
- Fast Write Cycle Times
 - Page Write Cycle Time: 10 ms Maximum (Standard)
 2 ms Maximum (Option Ref. AT28HC64BF Datasheet)
 - 1 to 64-byte Page Write Operation
- Low Power Dissipation
 - 40 mA Active Current
- 100 µA CMOS Standby Current
- Hardware and Software Data Protection
- DATA Polling and Toggle Bit for End of Write Detection
- High Reliability CMOS Technology
 - Endurance: 100,000 Cycles
 - Data Retention: 10 Years
- Single 5 V $\pm 10\%$ Supply
- CMOS and TTL Compatible Inputs and Outputs
- JEDEC Approved Byte-wide Pinout
- Industrial Temperature Ranges
- Green (Pb/Halide-free) Packaging Option

1. Description

The AT28HC64B is a high-performance electrically-erasable and programmable readonly memory (EEPROM). Its 64K of memory is organized as 8,192 words by 8 bits. Manufactured with Atmel's advanced nonvolatile CMOS technology, the device offers access times to 55 ns with power dissipation of just 220 mW. When the device is deselected, the CMOS standby current is less than 100 μ A.

The AT28HC64B is accessed like a Static RAM for the read or write cycle without the need for external components. The device contains a 64-byte page register to allow writing of up to 64 bytes simultaneously. During a write cycle, the addresses and 1 to 64 bytes of data are internally latched, freeing the address and data bus for other operations. Following the initiation of a write cycle, the device will automatically write the latched data using an internal control timer. The end of a write cycle can be detected by DATA polling of I/O7. Once the end of a write cycle has been detected, a new access for a read or write can begin.

Atmel's AT28HC64B has additional features to ensure high quality and manufacturability. The device utilizes internal error correction for extended endurance and improved data retention characteristics. An optional software data protection mechanism is available to guard against inadvertent writes. The device also includes an extra 64 bytes of EEPROM for device identification or tracking.



64K (8K x 8) High Speed Parallel EEPROM with Page Write and Software Data Protection

AT28HC64B



AT28HC64B

5. DC and AC Operating Range

	AT28HC64B-70	AT28HC64B-90	AT28HC64B-120
Operating Temperature (Case)	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C
V _{CC} Power Supply	5 V ±10%	5 V ±10%	5 V ±10%

6. Operating Modes

Mode	CE	ŌE	WE	I/O
Read	V _{IL}	V _{IL}	V _{IH}	D _{OUT}
Write ⁽²⁾	V _{IL}	V _{IH}	V _{IL}	D _{IN}
Standby/Write Inhibit	V _{IH}	X ⁽¹⁾	X	High Z
Write Inhibit	Х	Х	V _{IH}	
Write Inhibit	Х	V _{IL}	Х	
Output Disable	Х	V _{IH}	X	High Z
Chip Erase	V _{IL}	V _H ⁽³⁾	V _{IL}	High Z

Notes: 1. X can be VIL or VIH.

- 2. See "AC Write Waveforms" on page 8.
- 3. $VH = 12.0 V \pm 0.5 V.$

7. Absolute Maximum Ratings*

Temperature Under Bias55°C to +125°C
Storage Temperature65°C to +150°C
All Input Voltages (including NC Pins) with Respect to Ground0.6 V to +6.25 V
All Output Voltages with Respect to Ground0.6 V to V_{CC} + 0.6 V
Voltage on \overline{OE} and A9 with Respect to Ground0.6 V to +13.5V

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability

8. DC Characteristics

Symbol	Parameter	Condition	Min	Max	Units
I _{LI}	Input Load Current	$V_{IN} = 0 V \text{ to } V_{CC} + 1 V$		10	μA
I _{LO}	Output Leakage Current	$V_{I/O} = 0 V \text{ to } V_{CC}$		10	μA
I _{SB1}	V _{CC} Standby Current CMOS	$\overline{CE} = V_{CC} - 0.3 \text{ V to } V_{CC} + 1 \text{ V}$		100 ⁽¹⁾	μA
I _{SB2}	V _{CC} Standby Current TTL	$\overline{CE} = 2.0 \text{ V to V}_{CC} + 1 \text{ V}$		2 ⁽¹⁾	mA
I _{cc}	V _{CC} Active Current	f = 5 MHz; I _{OUT} = 0 mA		40	mA
V _{IL}	Input Low Voltage			0.8	V
V _{IH}	Input High Voltage		2.0		V
V _{OL}	Output Low Voltage	I _{OL} = 2.1 mA		0.40	V
V _{OH}	Output High Voltage	I _{OH} = -400 μA	2.4		V

Note: 1. I_{SB1} and I_{SB2} for the 55 ns part is 40 mA maximum.

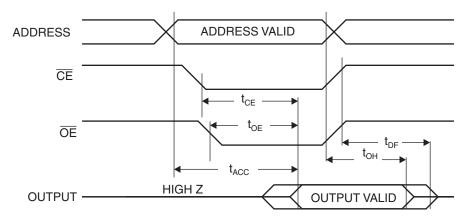




9. AC Read Characteristics

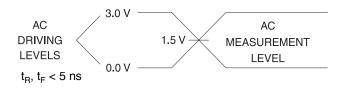
		AT28H	C64B-70	AT28HC64B-90		AT28HC64B-120			
Symbol	Parameter	Min	Max	Min	Max	Min	Max	Units	
t _{ACC}	Address to Output Delay		70		90		120	ns	
t _{CE} ⁽¹⁾	CE to Output Delay		70		90		120	ns	
t _{OE} ⁽²⁾	OE to Output Delay	0	35	0	40	0	50	ns	
t _{DF} ⁽³⁾⁽⁴⁾	OE to Output Float	0	35	0	40	0	50	ns	
t _{OH}	Output Hold	0		0		0		ns	

10. AC Read Waveforms⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾

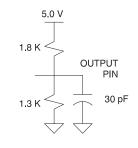


- Notes: 1. \overline{CE} may be delayed up to t_{ACC} t_{CE} after the address transition without impact on t_{ACC} .
 - OE may be delayed up to t_{CE} t_{OE} after the falling edge of CE without impact on t_{CE} or by t_{ACC} t_{OE} after an address change without impact on t_{ACC}.
 - 3. t_{DF} is specified from \overline{OE} or \overline{CE} whichever occurs first (C_L = 5 pF).
 - 4. This parameter is characterized and is not 100% tested.

11. Input Test Waveforms and Measurement Level



12. Output Test Load



13. Pin Capacitance

 $f = 1 \text{ MHz}, T = 25^{\circ}C^{(1)}$

Symbol	Тур	Мах	Units	Conditions
C _{IN}	4	6	pF	V _{IN} = 0 V
C _{OUT}	8	12	pF	V _{OUT} = 0 V

Note: 1. This parameter is characterized and is not 100% tested.



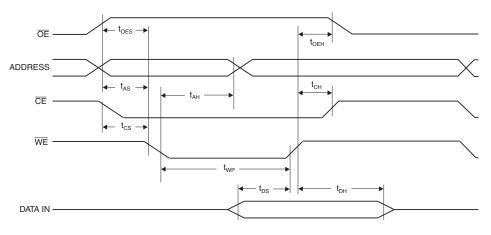


14. AC Write Characteristics

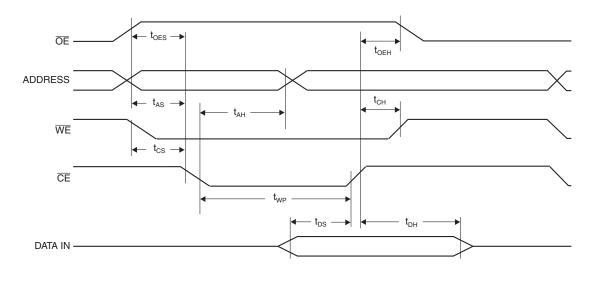
Symbol	Parameter	Min	Мах	Units	
t _{AS} , t _{OES}	Address, OE Setup Time	0		ns	
t _{AH}	Address Hold Time	ess Hold Time 50			
t _{cs}	Chip Select Setup Time	0		ns	
t _{CH}	Chip Select Hold Time	0		ns	
t _{WP}	Write Pulse Width (\overline{WE} or \overline{CE})	100		ns	
t _{DS}	Data Setup Time	50		ns	
t _{DH} , t _{OEH}	Data, OE Hold Time	0		ns	

15. AC Write Waveforms

15.1 WE Controlled



15.2 CE Controlled

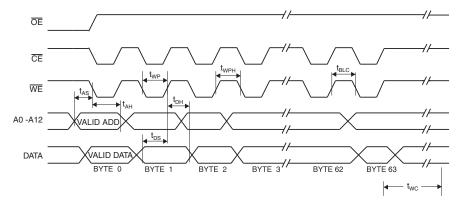


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16. Page Mode Characteristics

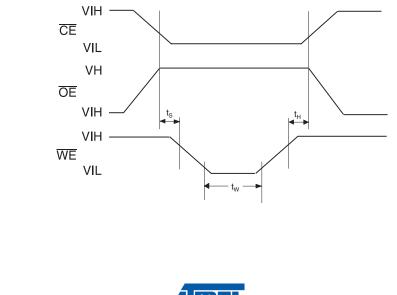
Symbol	Parameter	Min	Max	Units
t _{WC}	Write Cycle Time		10	ms
t _{WC}	Write Cycle Time (Use AT28HC64BF))		2	ms
t _{AS}	Address Setup Time	0		ns
t _{AH}	Address Hold Time	50		ns
t _{DS}	Data Setup Time	50		ns
t _{DH}	Data Hold Time	0		ns
t _{WP}	Write Pulse Width	100		ns
t _{BLC}	Byte Load Cycle Time		150	μs
t _{WPH}	Write Pulse Width High	50		ns

17. Page Mode Write Waveforms⁽¹⁾⁽²⁾



Notes: 1. A6 through A12 must specify the same page address during each high to low transition of WE (or CE).
2. OE must be high only when WE and CE are both low.

18. Chip Erase Waveforms



 $t_{S} = t_{H} = 5 \ \mu s \ (min.)$ $t_{W} = 10 \ ms \ (min.)$ $V_{H} = 12.0 \ V \ \pm 0.5 \ V$

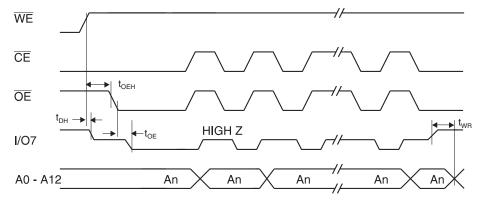


22. Data Polling Characteristics⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
t _{DH}	Data Hold Time	0			ns
t _{OEH}	OE Hold Time	0			ns
t _{OE}	OE to Output Delay ⁽¹⁾				ns
t _{WR}	Write Recovery Time	0			ns

Note: 1. These parameters are characterized and not 100% tested. See "AC Read Characteristics" on page 6.

23. Data Polling Waveforms



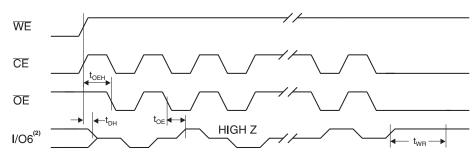
24. Toggle Bit Characteristics⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
t _{DH}	Data Hold Time	10			ns
t _{OEH}	OE Hold Time	10			ns
t _{OE}	OE to Output Delay ⁽²⁾				ns
t _{OEHP}	OE High Pulse	150			ns
t _{WR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See "AC Read Characteristics" on page 6.

25. Toggle Bit Waveforms⁽¹⁾⁽²⁾⁽³⁾



Notes: 1. Toggling either \overline{OE} or \overline{CE} or both \overline{OE} and \overline{CE} will operate toggle bit.

- 2. Beginning and ending state of I/O6 will vary.
- 3. Any address location may be used, but the address should not vary.



27. Ordering Information⁽¹⁾

27.1 Standard Package

t _{ACC}	cc I _{cc} (mA)				
(ns)	Active	Standby	Ordering Code	Package	Operation Range
			AT28HC64B-70JI	32J	
70	40	0.1	AT28HC64B-70PI	28P6	
70	40	0.1	AT28HC64B-70SI	28S	
			AT28HC64B-70TI	28T	
		40 0.1	AT28HC64B-90JI	32J	
90	40		0.1	AT28HC64B-90PI	28P6
90	40	0.1	AT28HC64B-90SI	28S	(-40°C to 85°C)
			AT28HC64B-90TI	28T	
			AT28HC64B-12JI	32J	
120	20 40	0.1	AT28HC64B-12PI	28P6	
120		0.1	AT28HC64B-12SI	28S	
			AT28HC64B-12TI	28T	

Note: 1. See "Valid Part Numbers" on page 13.

27.2 Green Package Option (Pb/Halide-free)

t _{ACC}	t _{ACC} I _{CC} (mA)						
(ns)	Active	Standby	Ordering Code	Package	Operation Range		
			AT28HC64B-70TU	28T			
70	40	0.1	AT28HC64B-70JU	32J			
			AT28HC64B-70SU	28S			
			AT28HC64B-90JU	32J			
90	40	10	10	40 04	AT28HC64B-90PU	28P6	Industrial
90	40	0.1	AT28HC64B-90SU	28S	(-40°C to 85°C)		
			AT28HC64B-90TU	28T			
100	40	0.1	AT28HC64B-12JU	32J			
120	120 40	40 0.1	AT28HC64B-12SU	28S			

Package Type		
32J	32-lead, Plastic J-leaded Chip Carrier (PLCC)	
28P6	28-lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)	
28S	28-lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC)	
28T	28-lead, Plastic Thin Small Outline Package (TSOP)	

28. Valid Part Numbers

The following table lists standard Atmel products that can be ordered.

Device Numbers	Speed	Package and Temperature Combinations
AT28HC64B	70	JI, PI, SI, TI, TU, JU, SU
AT28HC64B	90	JI, JU, PI, PU, SI, SU, TI, TU
AT28HC64B	12	JI, JU, PI, PU, SI, SU, TI, TU

29. Die Products

Reference Section: Parallel EEPROM Die Products



AT28HC64B

30.4 28T - TSOP

